

# **Elemental Analysis of Biological Samples using SEM EDS**

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Bruker Nano GmbH Am Studio 2D 12489 Berlin, Germany XFlash<sup>®</sup> Technology



#### Presenter



- Max Patzschke
- Working for 10 years as an application scientist for SEM/EDS and µXRF for Bruker Nano Analytics, Berlin, Germany
- In his previous employment as a senior mineralogist in the technical development department of Vale S.A. in Brazil, he was responsible for various analytical techniques such as QEMSCAN, SEM-EDS and XRD analysis, as well as mineral phase interpretation and sample preparation.
- Before that he worked in Australia for Intellection as a SEM/QEMSCAN operator and as a core logger for Gnomics Exploration and Barrick Gold.
- In 2008 he completed his Master of Science in mineralogy at the Free University Berlin



### Outline

SEM EDS analysis challenges

/ Technical details - FlatQUAD

RelatQUAD vs. conventional detector

Application examples – Biological topographic complex samples

05 Large area mapping
06 Summary



# **SEM-EDS analysis common challenges**

Charge accumulation Topography











# SEM-EDS analysis common challenges Sample charging

Charge accumulation

Topography









# SEM-EDS analysis common challenges Sample charging

Charge accumulation

Topography









# SEM-EDS analysis common challenges Sample charging

Charge accumulation

Topography

Low X-Ray yield









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# SEM-EDS analysis common challenges Topography

Charge accumulation

Topography









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AG: 370x Px: 0.27 L

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# SEM-EDS analysis common challenges Low X-ray yield

Charge accumulation

Topography











# **SEM-EDS analysis common challenges**

Charge accumulation

Topography









# **SEM-EDS analysis common challenges**

# How can we solve these challenges?

Charge accumulation

Topography







# SEM-EDS analysis common challenges SEM parameters we can change



- Low pressure
  - Reduce charging
  - Beam skirting effects
  - Reduce the spatial resolution
  - Contributions from environmental gas



- Low kV and low beam current:
  - Reduce charging
  - Protects beam sensitive samples
  - Spatial resolution reduced
  - Leads to low X-ray count rates
  - Longer measurement time
  - More overlapping peaks
  - Background subtraction more difficult

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#### SEM-EDS analysis common challenges Possible solutions

Possible solution with existing Hardware on the SEM!

- → Multiple EDS detectors (double detector system)
- → XFlash® FlatQUAD detector (4 detectors in 1)
- → XFlash® FlatQUAD inserted below pole piece -> high solid angle/collection efficiency





#### 4-segment annular EDS detector - XFlash<sup>®</sup> FlatQUAD Annular design with side entry







• Hole in the center for the e-beam surrounded by the 4 segments



- Side entry Similar to STEM or retractable BSE
- EDS detector under the polepiece above the sample
- Optimal geometry for signal collection
- Up to 2.400.000 cps throughput



#### XFlash® FlatQUAD Geometrical features compared to conventional EDS detector







- Shadowing minimized for topographic samples
- Highest solid angle (up to 1.1 sr)

High take-off angle (~60°-70°)



#### XFlash<sup>®</sup> FlatQUAD Analytical advantages





- High sensitivity, high signal low noise
- High count rate at low kV and low beam currents
- No/low shadowing for topographic samples
- Full quantitative mapping and quantification from each pixel in the map is possible







#### **Conventional detector vs. XFlash® FlatQUAD**



#### XFlash<sup>®</sup> FlatQUAD – vs. Conventional detector Aosa rupestris (Asteraceae family)



#### **Conventional EDS detector**



- 6 kV / Input count rate: 4,700 cps
- Pd coated
- Shadow effects

#### XFlash<sup>®</sup> FlatQUAD



- 6 kV / Input count rate: 58,700 cps
- Pd coated
- No shadow effects



#### **Conventional EDS detector Sting nettle plant (Urtica sp.)**



- Mapping parameters
  - 5-6kV
  - Measurement time: ~10min
  - Conventional EDS detector shows shadowing, charging and low input count rate



#### XFlash<sup>®</sup> FlatQUAD Sting nettle plant (Urtica sp.)





#### Topographic, beam sensitive samples measured with XFlash® FlatQUAD

#### **Biological samples measured with XFlash® FlatQUAD**





#### Aosa rupestris (Asteraceae family) Flowering nettle family





- Mapping parameters:
  - 6 kV
  - Beam current ~180 pA
  - Magnification: 168
  - Pixel spacing: 0,97µm



Sample curtesy of University Bonn



#### Aosa rupestris (Asteraceae family) Flowering head of Aosa rupestris



- Mapping parameters:
  - 6 kV
  - Beam current ~80 pA
  - Image 1200x900 pixel
  - Pd coated
  - Magnification: 180
  - Pixel spacing: 1,5µm



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## Aosa rupestris (Asteraceae family) Mineralization of silicon, calcium and phosphorus



• Mineralization of silicon, calcium and phosphorus







#### Echium hypertropicum Exhibits mineralized hairs fresh on cooling stage



- Mapping parameters:
  - 6 kV
  - Image resolution 1600x1200 pixel
  - Magnification: 389
  - Pixel spacing: 0,4 µm
  - Time: 155sec









#### Sample curtesy of University Bonn



#### Innovation with Integrity

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## Echium hypertropicum Potassium Regulation in Echium hypertropicum



- Mapping parameters:
  - 6 kV
  - Image 1600x1200 pixel
  - Magnification: 823
  - Pixel spacing: 0,2 µm
  - Time: 126 sec.

• The concentration of potassium observed around the stomata surrounding the hair, is essential for regulating their opening and closing



Sample curtesy of University Bonn



#### Leaf replicas made of synthetic resin **Pollution of Tungsten**





#### Mapping parameters:

- 7 kV
- Image 2048x1536 pixel
- Pixel spacing: 0,1µm



#### Sea Urchin Skeletons Biomineralization and Hierarchical Structures





• 6 kV / ~55,000 cps / 51 sec measurement time



#### Sea urchin skeleton structure No Shadowing





• 6 kV / ~58,000 cps / 51 sec measurement time

## Unveiling Microbial Mat Diversity in Yellowstone's Hot Springs No coating, no shadowing



- 6 kV / ~60,000 cps / 51 sec measurement time
- Diatoms (red) sticking to the bluish biofilm matrix



# Calcium Carbonate Crystallization in Yellowstone's Microbial Mats No coating, no shadowing







- 6 kV / ~50,000 cps / 51 sec measurement time,
- No sample preparation like carbon coating

## Unlock the secrets of marine life with cutting-edge technology Head of the polychaeta





- The head of Polychaeta, adorned with its mineralized bristles composed of calcium phosphate,
- These bristles, crafted from calcium phosphate, not only provide structural support to the organism but also serve a vital function in its defense mechanism
- Mapping parameters:
  - 10 kV
  - Image 2048x1536 pixel
  - Magnification: 160
  - Pixel spacing: 0,8 µm
  - Pd coated
  - Time: 176 sec.
  - WD 13 mm



Sample curtesy of University Bonn



# Head of the polychaeta Single element maps









MAG: 160x HV: 10 kV WD: 12,7 mm Px: 0,84 µm

AL MAG: 190x HV: 10 kV WD: 127 mm Pr: 0.84 um



#### Increase sample measurment area with one click Image Extension







#### Image Extension

- Use actual sample position as central Mapping position and define number of x/y frames around
- Result: one Hypermap file
- Image extension can be enlarged for a full sample map



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### Firebristle worm (polychaeta) Large area mapping over 16 fields in less then 3 minutes





- Mapping parameters:
  - 6 kV
  - 4x3 frames stitched together
  - Magnification: 170
  - Pixel spacing: 1,5 µm
- Polychaeta, with its mineralized bristles filled with a burning neurotoxin.
- The hollow, mineralized bristles, composed of calcium phosphate, play
   a crucial role in the worm's defense against predators.
   Sample curtesy of University Bonn





#### Low vacuum analysis Parasitoid wasp (Monolexis fuscicornis)



 Head of the wasp with mineralized tooth(Ca & P)



 Singel element maps from Ovipositor sting and egg-layer



• Overlapping element lines (Zn-L and Na-K) were separated with automatic online deconvolution during the mapping

In cooperation with: A. T. Kearsley & G. R. Broad (Natural History Museum, London)

• 6 kV / 240 sec / 12,000 cps

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# Winchcombe meteorite fall Light element detection



Carbon- and nitrogen-rich phases

#### • 6 kV / 158 pA / 38,000 cps

- King et al. Science Advances 2022
- Image: Dr. T. Salge: ©Trustees of the Natural History Museum, London, Lizenz: "CC BY 4.0



- Extraterrestrial Micrometre-sized calcite grains (blue) in the carbonaceous chondrite Winchcombe.
- King et al., Science (2023). DOI:<u>10.1126/sciadv.abq3925</u>
- Image: Dr. Tobias Salge



#### Molt of a bacon beetle Preservation methods



Bacon beetle

- Molt of a bacon beetle
- 12 kV / 240 sec / 12,000 cps



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#### Summary

The XFlash® FlatQUAD detector offers several key benefits for biological sample analysis:

- High Count Rate at Low kV: The detector maintains a high count rate even at low accelerating voltages (kV), allowing for detailed imaging and analysis of delicate biological samples without causing damage.
- High Sensitivity: The detector provides high sensitivity,
- High Signal-to-Noise Ratio: It produces a high signal-to-noise ratio, ensuring clear and precise imaging and analysis of biological structures and compositions.
- Minimized Shadowing Effects: It minimizes or eliminates shadowing effects, particularly beneficial for topographic samples with complex surface features.
- Large Field of View: With features like Image Extension, the detector enables the capture of a large field of view with a single click, facilitating comprehensive visualization and analysis of biological specimens.
- Elemental Mapping: Mapping of biological samples with the XFlash® FlatQUAD, providing insight into the distribution of elements and spectra information in each pixel.
- **Drift Correction**: Drift correction ensures precise pixel alignment when beam shift occurs.



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